

**Search Notes****Application/Control No.**

10/764,381

**Examiner**

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**Applicant(s)/Patent under Reexamination**

TRAN ET AL.

**Art Unit**

2824

**SEARCHED**

Class	Subclass	Date	Examiner
365	185.05	7/23/2006	SD
365	185.11	7/23/2006	SD
365	63	7/23/2006	SD
365	185.2	7/23/2006	SD
365	210	7/23/2006	SD

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	7/23/2006	SD

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner